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PATENT TRADEMARK

LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No.: 2002P14512US ~~TRADEMARK~~ Filing Date: August 25, 2003
 Serial No.: 10/647,647 Group Art: 2858 2854
 Applicant: Clifford Mark Kelly et al.

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EXAMINER: NOLAN DATE CONSIDERED: 8/31/04

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Atty Docket No.: 2002P14512US01 Filing Date: N/A 8/25/03
 Serial No.: ^{10/647,641} Concurrently Herewith Group Art: N/A 2854
 Applicant: Clifford Mark Kelly et al

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	AC	6,259,939 B1	07-10-2001	Rogel	600	390	04-21-1999
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